

STD55NH2LL STD55NH2LL-1

N-channel 24V - 0.010Ω - 40A - DPAK/IPAK Ultra low gate charge STripFET™ Power MOSFET

General features

Туре	V _{DSS}	R _{DS(on)}	I _D
STD55NH2LL-1	24V	<0.011Ω	40A ⁽¹⁾
STD55NH2LL	24V	<0.011Ω	40A ⁽¹⁾

- 1. Value limited by wire bonding
- R_{DS(ON)} * Qg industry's benchmark
- Conduction losses reduced
- Switching losses reduced
- Low threshold device

Description

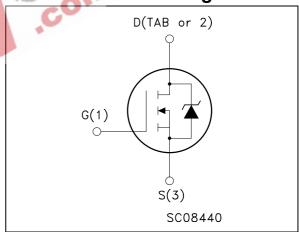
The STD55NH2LL is based on the latest generation of ST's proprietary STripFET™ technology. An innovative layout enables the device to also exhibit extremely low gate charge for the most demanding requirements as high-side switch in high-frequency DC-DC converters. It's therefore ideal for high-density converters in Telecom and Computer applications.

Applications

■ Switching application



Internal schematic diagram



Order codes

Part number	Marking	Package	Packaging
STD55NH2LL-1	D55NH2LL	IPAK	Tube
STD55NH2LLT4	D55NH2LL	DPAK	Tape & reel

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1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{spike} (1)	Drain-source voltage rating	30	V
V_{DS}	Drain-source voltage (V _{GS} = 0)	24	V
V _{DGR}	Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)	24	V
V _{GS}	Gate- source voltage	± 16	V
I _D ⁽²⁾	Drain current (continuous) at T _C = 25°C	40	Α
I _D ⁽²⁾	Drain current (continuous) at T _C = 100°C	28	Α
I _{DM} ⁽³⁾	Drain current (pulsed)	160	Α
P _{tot}	Total dissipation at T _C = 25°C	60	W
	Derating Factor	0.4	W/°C
E _{AS} (4)	Single pulse avalanche energy	600	mJ
T _{stg}	Storage temperature	EE to 175	°C
Tj	Max. operating junction temperature	-55 to 175	

- 1. Garanted when external R_g=4.7 Ω and t_f < t_{fmax}.
- 2. Value limited by wire bonding
- 3. Pulse width limited by safe operating area.
- 4. Starting $T_i = 25$ °C, $I_D = 20A$, $V_{DD} = 15V$

Table 2. Thermal data

Rthj-case	Thermal resistance junction-case max	2.5	°C/W
Rthj-amb	Thermal resistance junction-ambient max	100	°C/W
T _J	Maximum lead temperature for soldering purpose	275	°C

Electrical characteristics 2

(T_{CASE}=25°C unless otherwise specified)

Table 3. On/off states

Symbol	Parameter	Test conditions Min.		Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 25mA, V _{GS} =0	nA, V _{GS} =0 24			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	$V_{\rm DO} = {\rm max \ rating}$			1 10	μ Α μ Α
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 16V			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1			V
R _{DS(on)}	Static drain-source on resistance	$V_{GS} = 10V, I_D = 20A$ $V_{GS} = 4.5V, I_D = 20A$		0.010 0.012	0.011 0.0135	Ω Ω
Table 4.	Dynamic	A STATE OF THE STA				

Table 4. **Dynamic**

Symbol	Parameter	Parameter Test conditions Min.			Unit
9 _{fs} ⁽¹⁾	Forward transconductance	V _{DS} = 10V _, I _D = 10A	18		S
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 25V, f = 1MHz,$ $V_{GS} = 0$	990 385 40		pF pF pF
R_{G}	Gate Input Resistance	f = 1 MHz Gate DC Bias = 0 Test Signal Level = 20 mV Open Drain	1.3		Ω
t _{d(on)} t _r t _{d(off)} t _f	Turn-on delay time Rise time Turn-off delay time Fall time	V_{DD} = 10V, I_D = 20A R_G = 4.7 Ω V _{GS} = 4.5V (see <i>Figure 13</i>)	15 56 13 10		ns ns ns
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	$0.44V \le V_{DD} \le 10V$, $I_D = 40A$, $V_{GS} = 4.5V$, $R_G = 4.7\Omega$ (see Figure 14)	8.7 4.2 2.4	11	nC nC nC
Q _{oss} ⁽²⁾	Output charge	V _{DS} = 16 V, V _{GS} = 0 V	7.6		nC

^{1.} Pulsed: Pulse duration = 300 μ s, duty cycle 1.5 %.

^{2.} $Qoss = Coss^*\Delta Vin$, Coss = Cgd + Cds. See *Chapter 4: Appendix A*

Table 5. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current Source-drain current (pulsed)				40 160	A A
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 20A, V _{GS} = 0			1.3	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I_{SD} = 40A, di/dt = 100A/µs, V_{DD} = 15V, T_j = 150°C (see <i>Figure 15</i>)		32.5 28 1.7		ns nC A

- 1. Pulse width limited by safe operating area.
- 2. Pulsed: Pulse duration = 300 μ s, duty cycle 1.5 %



2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

Figure 2. Thermal impedance

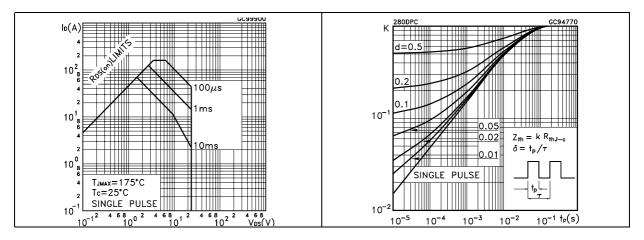


Figure 3. Output characterisics

Figure 4. Transfer characteristics

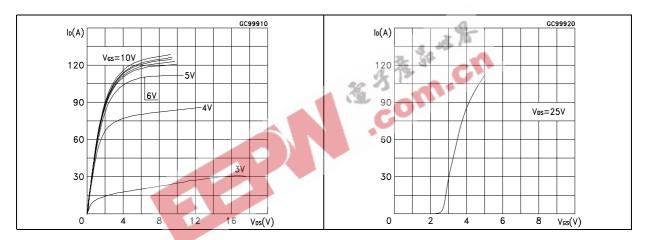


Figure 5. Transconductance

Figure 6. Static drain-source on resistance

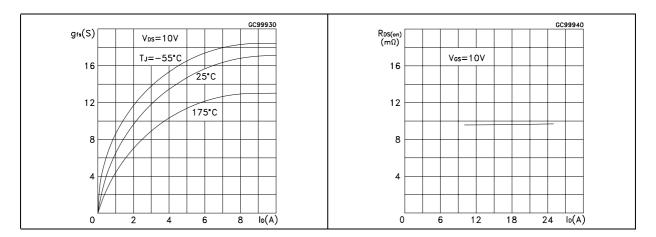


Figure 7. Gate charge vs gate-source voltage Figure 8. Capacitance variations

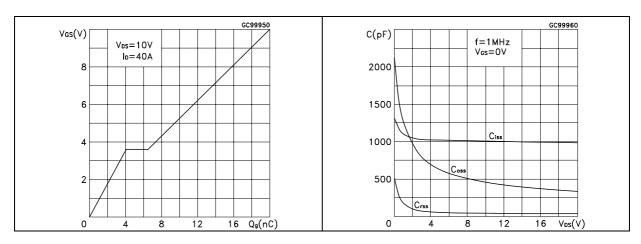


Figure 9. Normalized gate threshold voltage vs temperature

Figure 10. Normalized on resistance vs temperature

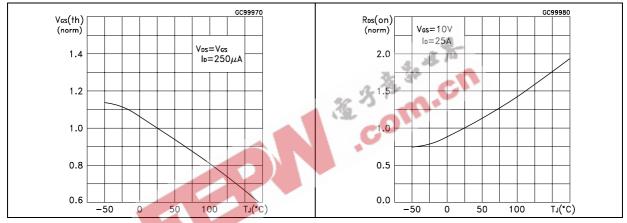
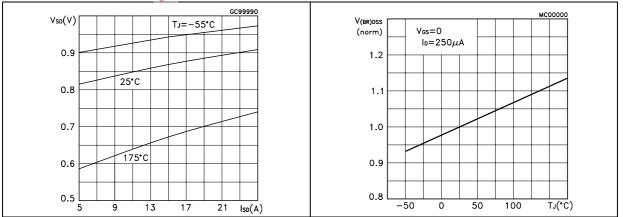


Figure 11. Source-drain diode forward characteristics

Figure 12. Normalized breakdown voltage vs temperature



3 Test circuit

Figure 13. Switching times test circuit for resistive load

Figure 14. Gate charge test circuit

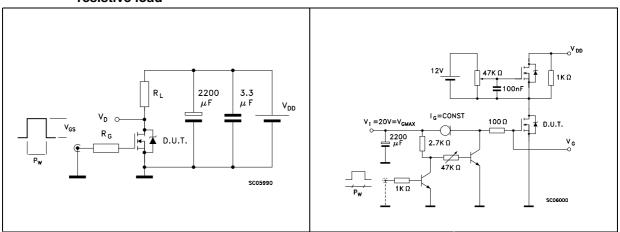


Figure 15. Test circuit for inductive load switching and diode recovery times

Figure 16. Unclamped Inductive load test

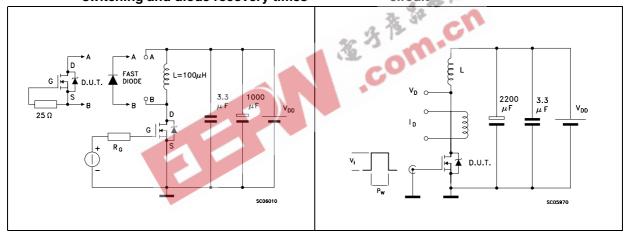
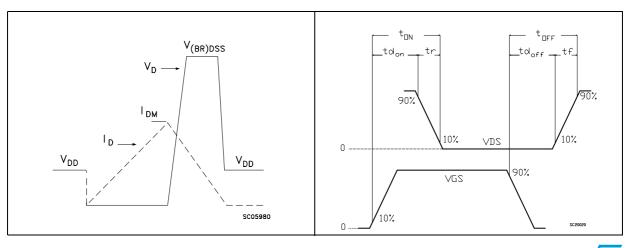


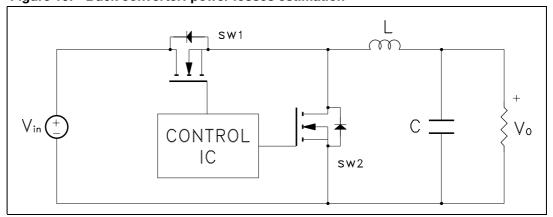
Figure 17. Unclamped inductive waveform

Figure 18. Switching time waveform



4 Appendix A

Figure 19. Buck converter: power losses estimation



The power losses associated with the FETs in a synchronous buck converter can be estimated using the equations shown in the table below. The formulas give a good approximation, for the sake of performance comparison, of how different pairs of devices affect the converter efficiency. However a very important parameter, the working temperature, is not considered. The real device behavior is really dependent on how the heat generated inside the devices is removed to allow for a safer working junction temperature.

- The low side (SW2) device requires:
- Very low R_{DS(on)} to reduce conduction losses
- Small Qgls to reduce the gate charge losses
- Small Coss to reduce losses due to output capacitance
- Small Qrr to reduce losses on SW1 during its turn-on
- The Cgd/Cgs ratio lower than Vth/Vgg ratio especially with low drain to source
- voltage to avoid the cross conduction phenomenon;
- The high side (SW1) device requires:
- Small Rg and Ls to allow higher gate current peak and to limit the voltage feedback on the gate
- Small Qg to have a faster commutation and to reduce gate charge losses
- Low R_{DS(on)} to reduce the conduction losses.

Table 6. Power losses calculation

		High side switching (SW1)	Low side switch (SW2)
Pconduction		$R_{DS(on)SW1} * I_L^2 * \delta$	$R_{DS(on)SW2} * I_L^2 * (1 - \delta)$
Pswitching		$V_{\text{in}} * (Q_{\text{gsth(SW1)}} + Q_{\text{gd(SW1)}}) * f * \frac{I_L}{I_g}$	Zero Voltage Switching
Pdiode	Recovery (1)	Not applicable	$V_{in} * Q_{rr(SW2)} * f$
ruiode	Conductio n	Not applicable	$V_{f(SW2)} * I_L * t_{deadtime} * f$
Pgate(Q _G)		$Q_{g(SW1)} * V_{gg} * f$	$Q_{gls(SW2)} * V_{gg} * f$
P _{Qoss}		$\frac{V_{\text{in}} * Q_{\text{oss(SW1)}} * f}{2}$	$\frac{V_{\text{in}} * Q_{\text{oss(SW2)}} * f}{2}$

^{1.} Dissipated by SW1 during turn-on

Table 7. Paramiters meaning

Parameter	Meaning
d	Duty-cycle
Q _{gsth}	Post threshold gate charge
Q _{gls}	Third quadrant gate charge
Pconduction	On state losses
Pswitching	On-off transition losses
Pdiode	Conduction and reverse recovery diode losses
Pgate	Gate drive losses
P _{Qoss}	Output capacitance losses

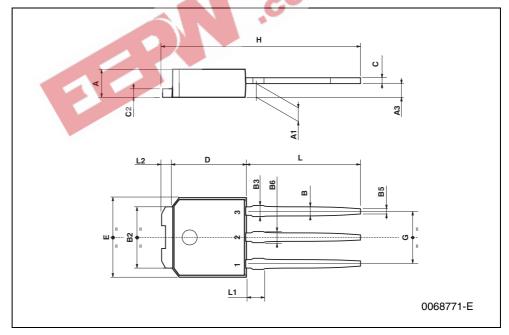
5 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com



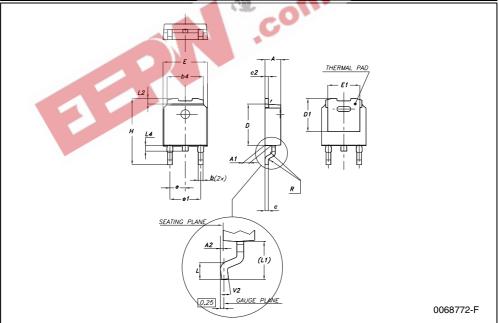
TO-251 (IPAK) MECHANICAL DATA

DIM.		mm		inch		
DIIVI.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
Α	2.2		2.4	0.086		0.094
A1	0.9		1.1	0.035		0.043
A3	0.7		1.3	0.027		0.051
В	0.64		0.9	0.025		0.031
B2	5.2		5.4	0.204		0.212
В3			0.85			0.033
B5		0.3			0.012	
B6			0.95			0.037
С	0.45		0.6	0.017		0.023
C2	0.48		0.6	0.019		0.023
D	6		6.2	0.236		0.244
Е	6.4		6.6	0.252		0.260
G	4.4		4.6	0.173		0.181
Н	15.9		16.3	0.626	_	0.641
L	9		9.4	0.354		0.370
L1	0.8		1.2	0.031		0.047
L2		0.8	13.14	280	0.031	0.039



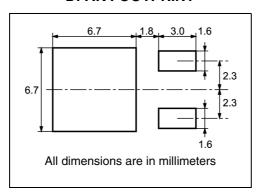
DPAK MECHANICAL DATA

DIM.		mm.			inch	
DIM.	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
Α	2.2		2.4	0.086		0.094
A1	0.9		1.1	0.035		0.043
A2	0.03		0.23	0.001		0.009
В	0.64		0.9	0.025		0.035
b4	5.2		5.4	0.204		0.212
С	0.45		0.6	0.017		0.023
C2	0.48		0.6	0.019		0.023
D	6		6.2	0.236		0.244
D1		5.1			0.200	
E	6.4		6.6	0.252		0.260
E1		4.7			0.185	
е		2.28			0.090	
e1	4.4		4.6	0.173		0.181
Н	9.35		10.1	0.368		0.397
L	1			0.039		
(L1)		2.8		42	0.110	
L2		0.8		4 15 11	0.031	
L4	0.6		1	0.023	•	0.039
R		0.2	a	13 6	0.008	
V2	0°		8°	0°		8°

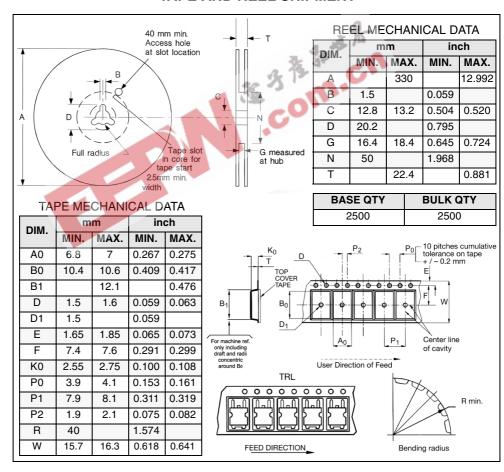


6 Packing mechanical data

DPAK FOOTPRINT



TAPE AND REEL SHIPMENT



7 Revision history

Table 8. Revision history

Date	Revision	Changes
22-Jun-2004	2	Preliminary datasheet
21-Jul-2005	3	Complete version
13-Jun-2006	4	Packing mechanical data inserted
16-Jul-2006	5	New template, no content change



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